

AN3925K

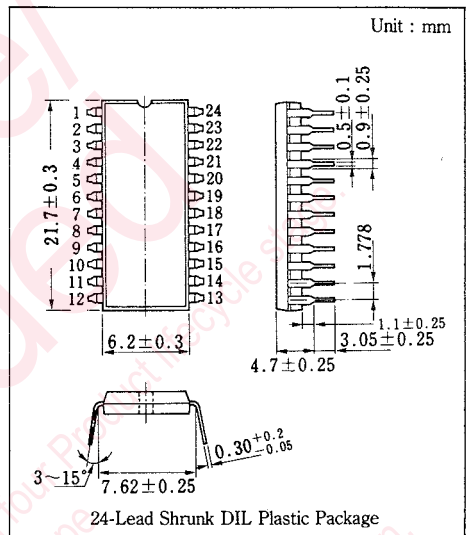
Hi-Fi VTR Input Select and AGC Circuit

Outline

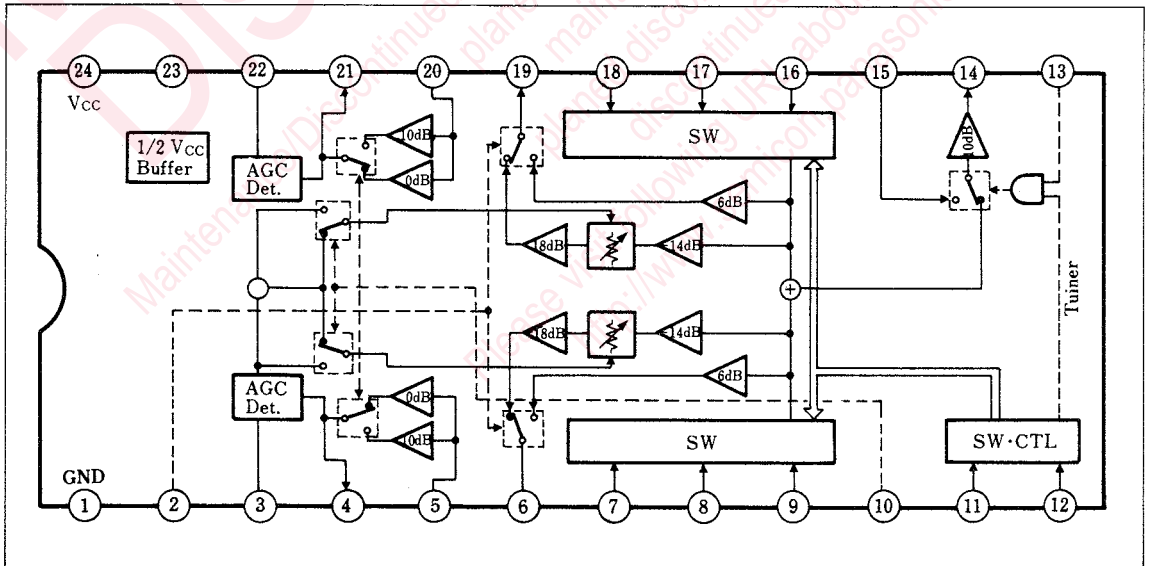
The AN3925K is an integrated circuit designed for a Hi-Fi VTR audio input circuit.

Features

- The functions consist of:
 - Audio signal input select circuit (stereo each 3ch+sub audio)
 - Automatic gain control
- Supply voltage: 5V



Block Diagram



■ Pin

Pin No.	Pin Name	Pin No.	Pin Name
1	GND	13	NORMAL CTL
2	AGC/MAN. CTL	14	NORMAL Output
3	AGC Capacitor	15	EXT. Input
4	L-ch. Output	16	R-ch. TUNER Input
5	L-ch. 2nd Amp. Input	17	R-ch. MIC Input
6	L-ch. 2nd Amp. Output	18	R-ch. LINE Input
7	L-ch. LINE Input	19	R-ch. 1st Amp. Output
8	L-ch. MIC Input	20	R-ch. 2nd Amp. Input
9	L-ch. TUNER Input	21	R-ch. Output
10	ST/BIL CTL	22	AGC Capacitor
11	Switch A	23	1/2V _{cc}
12	Switch B	24	V _{cc}

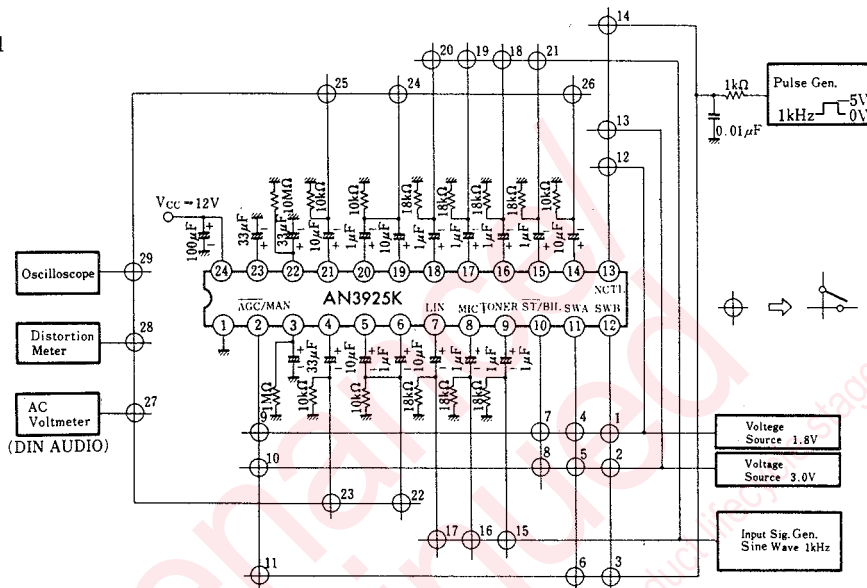
■ Absolute Maximum Ratings (T_a=25°C)

Item	Symbol	Rating	Unit
Supply Voltage	V _{cc}	14.4	V
Power Dissipation	P _D	420	mW
Operating Ambient Temperature	T _{opr}	-20~+75	°C
Storage Temperature	T _{stg}	-55~+150	°C

■ Electrical Characteristics (V_{cc}=12V, T_a=25°C)

Item	Symbol	Test Circuit	Condition	min.	typ.	max.	Unit
Static Circuit Current	I _{CQ}			2	6	13	mA
Normal Output Gain (MIX)	G _{NMX}	1	v _{in} =-20dBV	8.5	10	11.5	dB
Normal Output Gain (EXT)	G _{NEX}	1	v _{in} =-20dBV	8.5	10	11.5	dB
Normal Output Distortion Rate	T _N	1	v _{in} =-20dBV	0	0.02	0.05	%
AGC Output Level	V _{AGC}	1	v _{in} =-17dBV	-17.5	-16	-14.5	dBV
AGC Output Distortion Rate	T _{AGC}	1	v _{in} =-17dBV	0	0.07	0.15	%
AGC Output Level Difference(1)	V _{DEF1}	1	R Output-L Output	-0.8	0	0.8	dB
AGC Output Level Difference(2)	V _{DEF2}	1	v _{in} =-17dBV, 0dBV	-1.0	-0.3	0.3	dB
AGC Output Level Difference(3)	V _{DEF3}	1	ST Mode-BIL Mode	-0.8	0	0.8	dB
Manual Output Gain	G _{MAN}	1	v _{in} =-20dBV	13.7	16	17.7	dB
Manual Output Distortion Rate	T _{MAN}	1	v _{in} =-20dBV	0	0.02	0.05	%
Manual Maximum Output Voltage	V _{MAN}	1	THD=0.3%	2.9	3.2		V
AGC Output Noise	V _{NAGC}	1	Input 18kΩ Trailing End	0	22	30	μV
Manual Output Noise	V _{NMAN}	1	Input 18kΩ Trailing End	0	23	31	μV
Crosstalk between Channels	V _{ch}	1	v _{in} =-20dBV		-75	-70	dBV
L/R Crosstalk	V _{LR}	1	v _{in} =-20dBV		-80	-75	dBV
Normal Output Crosstalk	V _{NC}	1	v _{in} =-20dBV		-80	-75	dBV
Control Input High	V _{IN}			3		12	V
Control Low	V _{IL}			0		1.8	V

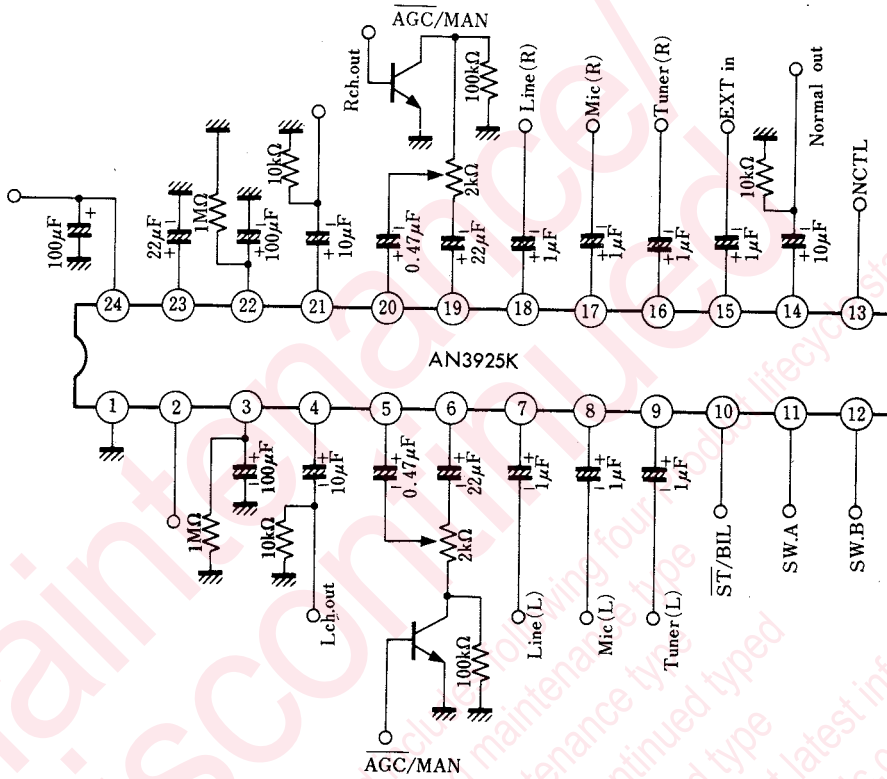
Test Circuit 1



■ Measuring Conditions List

Item	Input Signal	Switching Conditions (ON)				Reference
		Control	Input	Output	Measurement	
G _{NMX}	100mV	1,4,7,10,12	17,20	26	28	
G _{NEX}	100mV	1,5,7,10,13	21	26	28	
T _N	100mV	1,5,8,10,13	21	26	28	
V _{AGC}	140mV	2,4,8,9,13	19	25	28	R-ch
	140mV	2,4,8,9,13	16	23	28	L-ch
T _{AGC}	140mV	1,5,8,9,13	18	25	28	R-ch
	140mV	1,5,8,9,13	15	23	28	L-ch
V _{DEF1}	140mV	2,5,7,9,13	19	25	28	AGC Output Level Difference(1)
	140mV	2,5,7,9,13	16	23	28	= (7-1)/(7-2)
V _{DEF2}	1V	1,4,8,9,13	20	25	28	AGC Output R-ch = (5-1)/(8-1)
	1V	1,4,8,9,13	17	23	28	Level Difference(2) L-ch = (5-2)/(8-2)
V _{DEF3}	No Measurement					AGC Output R-ch = (5-1)/(7-1)
	No Measurement					Level Difference(3) L-ch = (5-2)/(7-2)
G _{MAN}	100mV	1,4,8,10,13	20	25	28	R-ch
	100mV	1,4,8,10,13	17	23	28	L-ch
T _{MAN}	100mV	2,4,8,10,13	19	25	28	R-ch
	100mV	2,4,8,10,13	16	23	28	L-ch
V _{MAN}	1.6V	1,5,8,10,13	18	24	28	R-ch
	1.6V	1,5,8,10,13	15	22	28	L-ch
V _{NAGC}	(R _s = 18kΩ)	1,4,7,9,13	-	25	27	R-ch. LINE Input
	(R _s = 18kΩ)	1,4,7,9,13	-	23	27	L-ch. LINE Input
	(R _s = 18kΩ)	2,4,7,10,13	-	25	27	R-ch. MIC Input
	(R _s = 18kΩ)	1,5,7,10,13	-	25	27	R-ch. TUNER Input
	(R _s = 18kΩ)	2,4,7,10,13	-	23	27	L-ch. MIC Input
V _{NMAN}	(R _s = 18kΩ)	1,5,7,10,13	-	23	27	L-ch. TUNER Input
	100mV	1,4,7,10,12	15,16 18,19	26	27	When LINE is Selected
	100mV	2,4,7,10,12	15,17 18,20	26	27	When MIC is Selected
	100mV	1,5,7,10,12	16,17 19,20	26	27	When TUNER is Selected
	100mV	2,5,7,10,13	16	25	27	L→R
V _{LR}	100mV	2,5,7,10,13	19	23	27	R→L
	100mV	1,5,8,10,13	20	26	27	When EXT IN is Selected
V _{NC}	100mV	1,5,7,10,12	21	26	27	When TUNER is Selected

Application Circuit



SW	A	B	NOUT	TUNER	NCTL
LINE	L	L	EXT. IN	H	H
TUNER	H	L	L+R	L	-
MIC	-	H		-	L

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